

Notice of References Cited	Application/Control No. 10/075,051	Applicant(s)/Patent Under Reexamination WANG ET AL.	
	Examiner Djenane M. Bayard	Art Unit 2141	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0199014	12-2002	Yang et al.	709/238
*	C	US-6,351,812	02-2002	Datar et al.	713/182
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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